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Compressive Optical Image Encryption, Volume 2

Guest Editors:

Dr. Marwa Elbouz

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Deadline for manuscript submissions:

closed (31 January 2024)

Message from the Guest Editors

This special issue will gather a series of articles dealing with the Compressive Optical Image Encryption. The session topics include, but are not limited, following areas:

- Optical/digital cryptography
- Optical/digital Watermarking
- Optical/digital biometrics
- Compressive Image
- Compressive sensing for images
- Compressive Optical Image Encryption
- Image Compression for Medical Image Processing Domain
- Optical cryptanalysis
- Novel devices and systems for optical information security
- Face/ Finger print/face/iris/Person recognition, Person tracking, 3D object recognition
- Liveness detection for face recognition
- Holography, Phase Imaging, and their applications
- Integral imaging
- Devices and systems for 3D imaging and display
- Polarization imaging
- Remote sensing: aerial and satellite image interpretations
- Industrial applications (e.g., product inspection/sorting)
- Spectral/Spatial Hyperspectral Image Compression

Papers submitted in advance will be peer-reviewed and may be published well before this deadline. For more details, please click here









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Message from the Editor-in-Chief

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